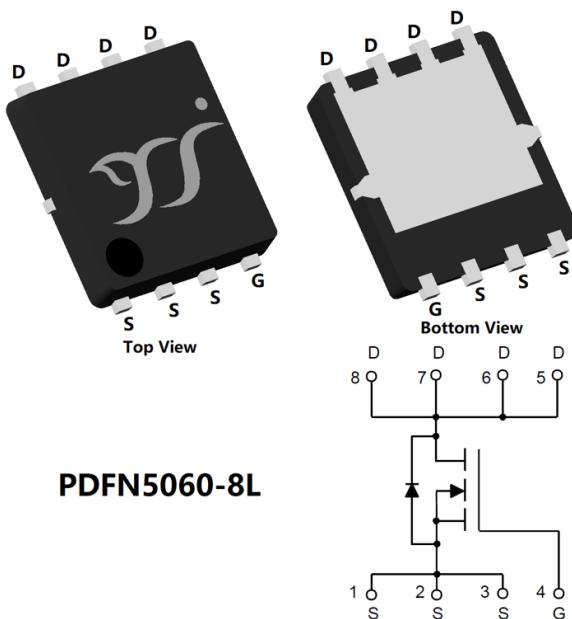




N-Channel Enhancement Mode Field Effect Transistor



Product Summary

- V_{DS} 40V
- I_D 200A
- $R_{DS(ON)}$ (at $V_{GS}=10V$) $<1.3m\Omega$
- 100% EAS Tested
- 100% ∇V_{DS} Tested

General Description

- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free
- Part no. with suffix "Q" means AEC-Q101 qualified

Applications

- Power switching application
- Uninterruptible power supply
- DC-DC convertor

Absolute Maximum Ratings ($T_A=25^\circ C$ unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-source Voltage		V_{DS}	40	V
Gate-source Voltage		V_{GS}	± 20	V
Drain Current	$T_c=25^\circ C$	I_D	200	A
	$T_c = 100^\circ C$		141	
	$T_A=25^\circ C$		27	
	$T_A = 100^\circ C$		19	
Pulsed Drain Current ^A		I_{DM}	600	A
Avalanche energy ^B		EAS	625	mJ
Total Power Dissipation ^C	$T_c=25^\circ C$	P_D	125	W
	$T_c = 100^\circ C$		62.5	
	$T_A=25^\circ C$		2.7	
	$T_A = 100^\circ C$		1.3	
Junction and Storage Temperature Range		T_J, T_{STG}	-55~+175	°C

Thermal resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient ^D	Steady-State	$R_{\theta JA}$	45	54	°C/W
Thermal Resistance Junction-to-Case	Steady-State	$R_{\theta JC}$	1	1.2	

Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJG200G04BRQ	F1	G200G04BR	5000	10000	100000	13" reel



YJG200G04BRQ

■ Electrical Characteristics (T_J=25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D =250μA	40	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =40V, V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} =0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D =250μA	1	1.7	2.5	V
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =20A		0.95	1.3	mΩ
		V _{GS} =4.5V, I _D =20A		1.3	2	mΩ
Diode Forward Voltage	V _{SD}	I _S =20A, V _{GS} =0V		0.77	1.2	V
Gate resistance	R _G	f=1MHz		1.2		Ω
Dynamic Parameters						
Input Capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1MHz	-	7700	-	pF
Output Capacitance	C _{oss}		-	1460	-	
Reverse Transfer Capacitance	C _{rss}		-	122	-	
Switching Parameters						
Total Gate Charge	Q _g	V _{GS} =10V, V _{DS} =20V, I _D =100A	-	131	-	nC
Gate-Source Charge	Q _{gs}		-	31.3	-	
Gate-Drain Charge	Q _{gd}		-	24	-	
Reverse Recovery Charge	Q _{rr}	I _F =40A, di/dt=100A/us	-	58.5	-	nC
Reverse Recovery Time	t _{rr}		-	52	-	ns
Turn-on Delay Time	t _{D(on)}	V _{GS} =10V, V _{DD} =20V, I _D =100A R _{GEN} =3Ω	-	19.5	-	ns
Turn-on Rise Time	t _r		-	35	-	
Turn-off Delay Time	t _{D(off)}		-	80	-	
Turn-off fall Time	t _f		-	31	-	

- A. Repetitive rating; pulse width limited by max. junction temperature.
- B. T_J=25°C, V_{DD}=30V, V_G=10V, R_G=25Ω, L=0.5mH, IAS=50A.
- C. P_d is based on max. junction temperature, using junction-case thermal resistance.
- D. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in the still air environment with T_A=25°C. The maximum allowed junction temperature of 175°C. The value in any given application depends on the user's specific board design.

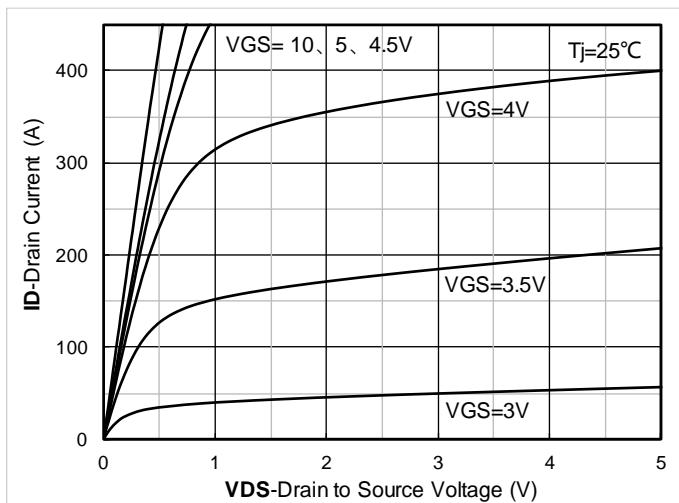
**■Typical Electrical and Thermal Characteristics Diagrams**

Figure 1. Output Characteristics

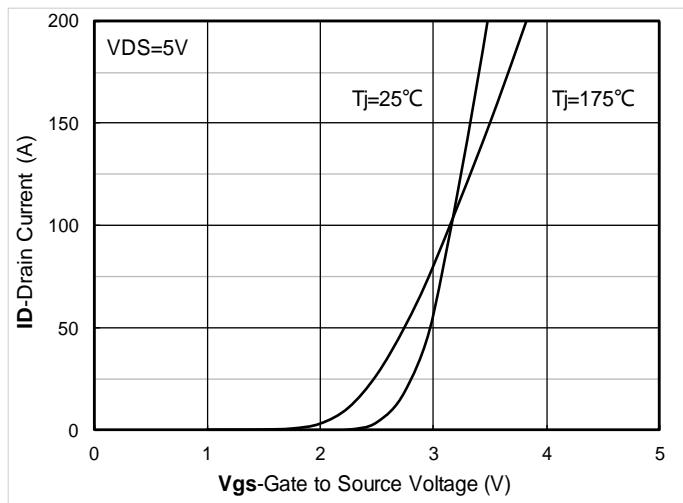


Figure 2. Transfer Characteristics

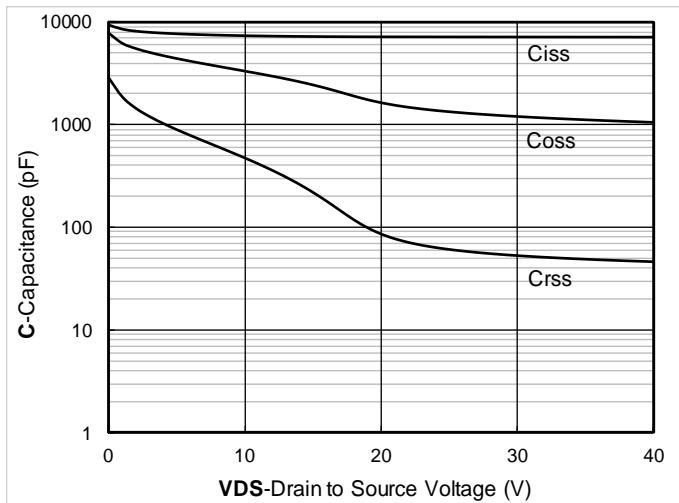


Figure 3. Capacitance Characteristics

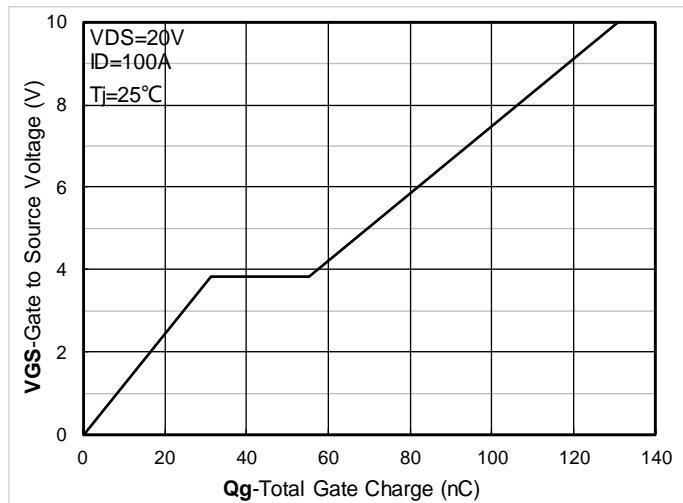


Figure 4. Gate Charge

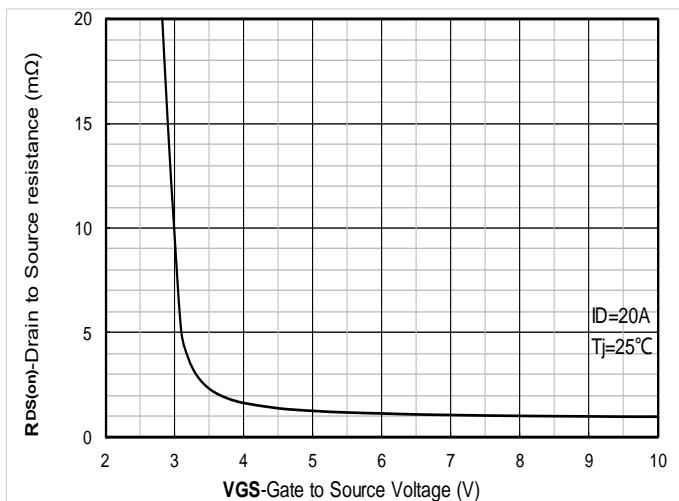


Figure 5. On-Resistance vs Gate to Source Voltage

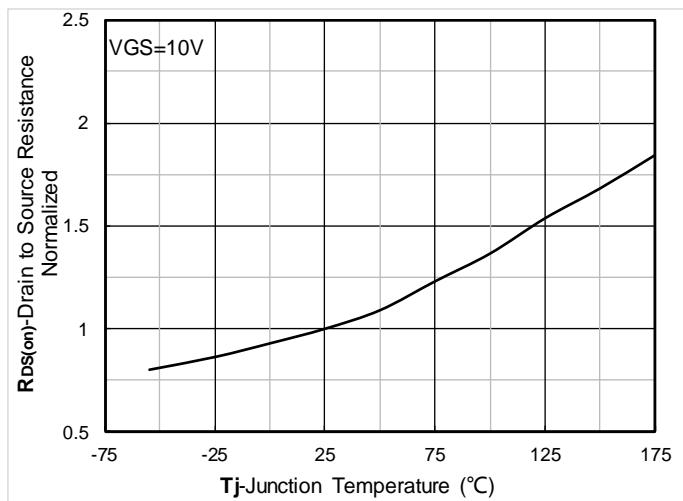


Figure 6. Normalized On-Resistance

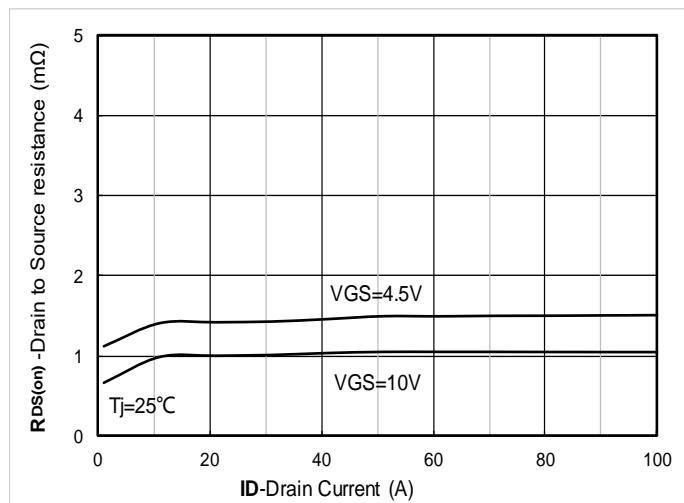
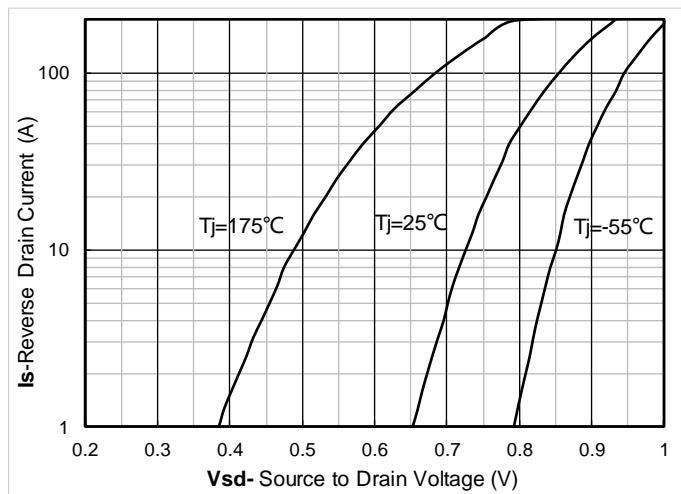
Figure 7. $R_{DS(on)}$ VS Drain Current

Figure 8. Forward characteristics of reverse diode

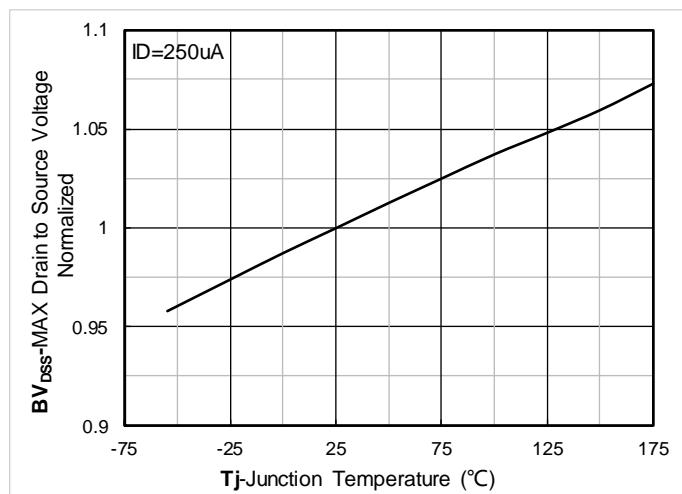


Figure 9. Normalized breakdown voltage

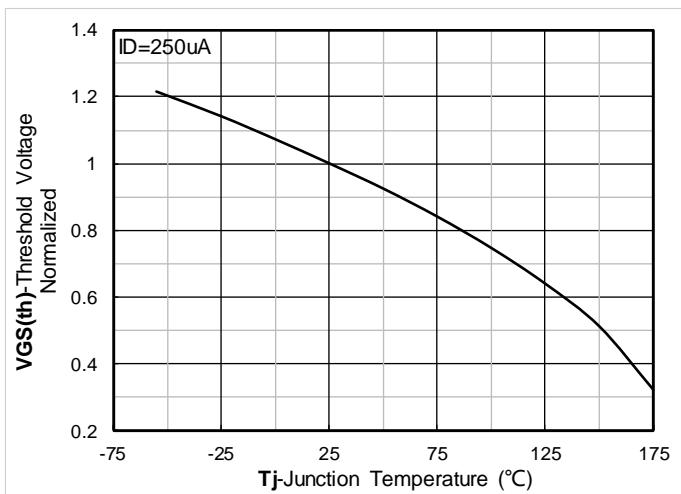


Figure 10. Normalized Threshold voltage

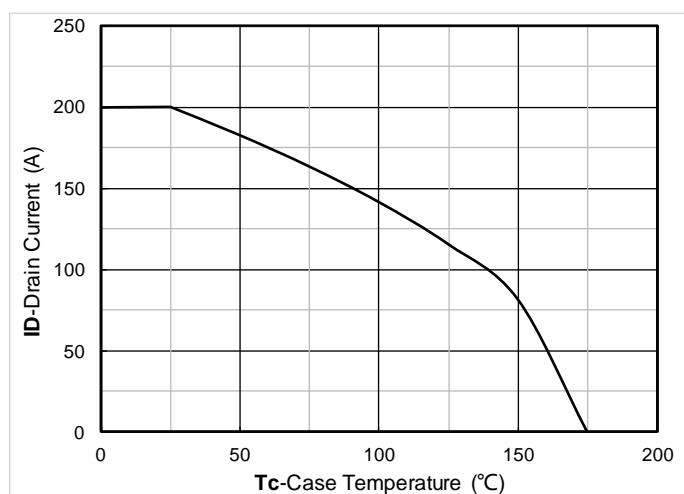


Figure 11. Current dissipation

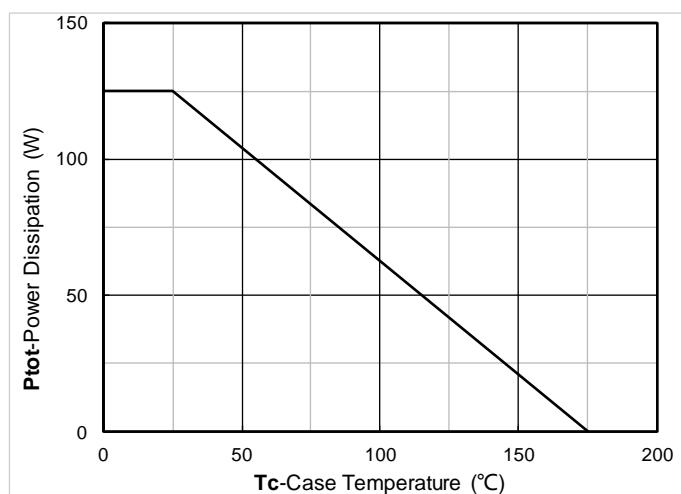


Figure 12. Power dissipation

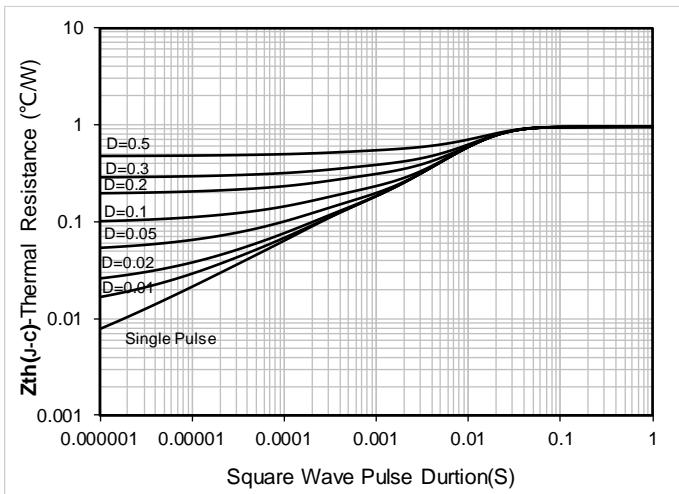


Figure 13. Maximum Transient Thermal Impedance

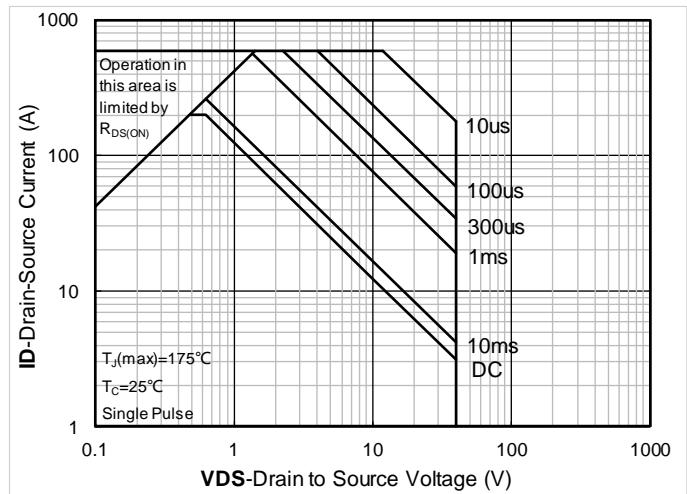
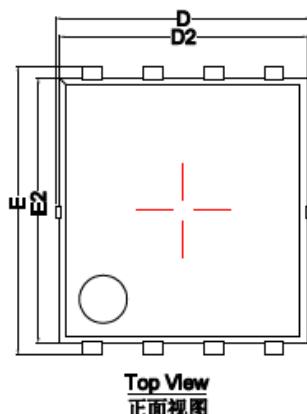
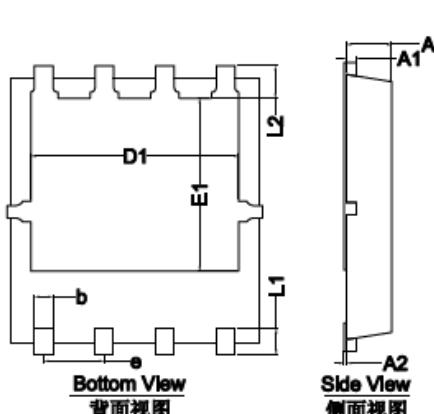
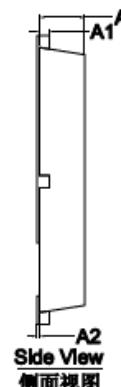


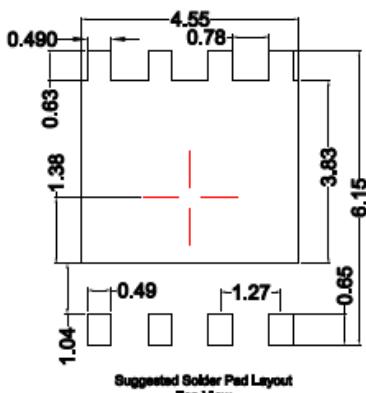
Figure 14. Safe Operation Area



■ PDFN5060-8L-0.95MM Package information

Top View
正面视图Bottom View
背面视图Side View
侧面视图

SYMBOL	MILLIMETER		
	MIN	NOM	MAX
D	5.15	5.35	5.55
E	5.95	6.05	6.15
A	0.85	0.95	1.05
A1		0.203 BSC	
A2			0.08
D1	4.25	4.35	4.45
E1	3.525	3.625	3.725
D2		5.20	
E2		5.55	
L1	0.45	0.55	0.65
L2		0.68 BSC	
b	0.3	0.4	0.5
e		1.27 BSC	



Suggested Solder Pad Layout

Top View

Note:

1. Controlling dimension: in millimeters.
2. General tolerance: $\pm 0.10\text{mm}$.
3. The pad layout is for reference purposes only.



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